

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/742,933 MIYACHI ET AL.	
		Examiner	Art Unit	Page 1 of 1 William Boddie 2674

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-5,488,389	01-1996	Nakanishi et al.	345/670
B	US-6,219,017	04-2001	Shimada et al.	345/88
C	US-4,937,667	06-1990	Choquet et al.	348/448
D	US-6,909,472	06-2005	Gadeyne et al.	348/750
E	US-6,333,727	12-2001	Mizumaki, Hidetaka	345/690
F	US-6,295,091	09-2001	Huang, Samson	348/448
G	US-2003/0090449	05-2003	Arimoto et al.	345/87
H	US-6,507,346	01-2003	Otera, Atsushi	345/606
I	US-6,567,097	05-2003	Iwaki, Tsutomu	345/603
J	US-RE35,093	11-1995	Wang et al.	348/413.1
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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